


<b>Search Notes</b>  	<b>Application/Control No.</b>  10550102	<b>Applicant(s)/Patent Under Reexamination</b>  YOKOTAGAWA ET AL.
	<b>Examiner</b>  Niebauer, Ronald T	<b>Art Unit</b>  1609

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Inventor search in EAST, eDAN; STIC search on SEQ ID NO:1 (results in eDAN)	4/16/07	rtn
PubMed, EAST search	4/16/07	rtn

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>